



**Product Change Notification / ASER-15HQCX332**

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**Date:**

20-Oct-2021

**Product Category:**

Analog to Digital Converters

**PCN Type:**

Manufacturing Change

**Notification Subject:**

CCB 4903 Final Notice: Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package.

**Affected CPNs:**

[ASER-15HQCX332\\_Affected\\_CPN\\_10202021.pdf](#)  
[ASER-15HQCX332\\_Affected\\_CPN\\_10202021.csv](#)

**Notification Text:**

**PCN Status:**Final Notification

**PCN Type:**Manufacturing Change

**Microchip Parts Affected:**Please open one of the files found in the Affected CPNs section.  
Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

**Description of Change:**Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package.

**Pre and Post Change Summary:**

	Pre Change	Post Change

Assembly Site	UTAC Thai Limited (UTL-1) LTD. (NSEB)	UTAC Thai Limited (UTL-1) LTD. (NSEB)
Wire Material	Au	Au
Die Attach Material	8200T	8200T
Molding Compound Material	G600	G600
Lead-Frame Material	C7025	C7025
Lead-Frame Paddle Size	82x94 mil	68x94 mil
Lead-Frame Lead Lock	No	Yes
	See Pre and Post Change Summary for comparison.	

**Impacts to Data Sheet:**None

**Change Impact:**None

**Reason for Change:**To improve productivity by qualifying a new lead frame design.

**Change Implementation Status:**In Progress

**Estimated First Ship Date:**10/30/21 (date code: 2144)

Note: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

**Time Table Summary:**

	October 2021				
Workweek	4 1	4 2	4 3	4 4	4 5
Qual Report Availability			x		
Final PCN Issue Date			x		
Estimated Implementation Date				x	

**Method to Identify Change:**Traceability code

**Qualification Report:**Please open the attachments included with this PCN labeled as PCN\_#\_Qual\_Report.

**Revision History:**October 20, 2021: Issued final notification.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

## **Attachments:**

[PCN\\_ASER-15HQCX332 Qual Report 1 of 2.pdf](#)

[PCN\\_ASER-15HQCX332 Qual Report 2 of 2.pdf](#)

[PCN\\_ASER-15HQCX332\\_Pre and Post Change Summary.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

## **Terms and Conditions:**

If you wish to [receive Microchip PCNs via email](#) please register for our PCN email service at our [PCN home page](#) select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the [PCN FAQ](#) section.

If you wish to [change your PCN profile, including opt out](#), please go to the [PCN home page](#) select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

Affected Catalog Part Numbers (CPN)

MCP3423-E/UN

MCP3427-E/UN

MCP3423T-E/UN

MCP3427T-E/UN

**CCB 4903**  
**Pre and Post Change Summary**  
**PCN #: ASER-15HQCX332**



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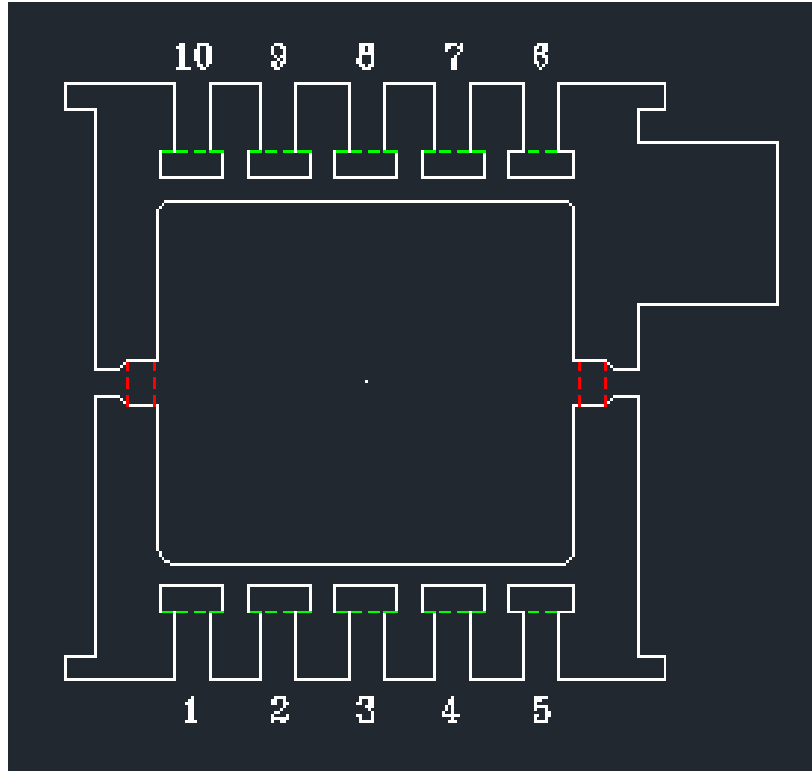
**Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package.**



SMART | CONNECTED | SECURE

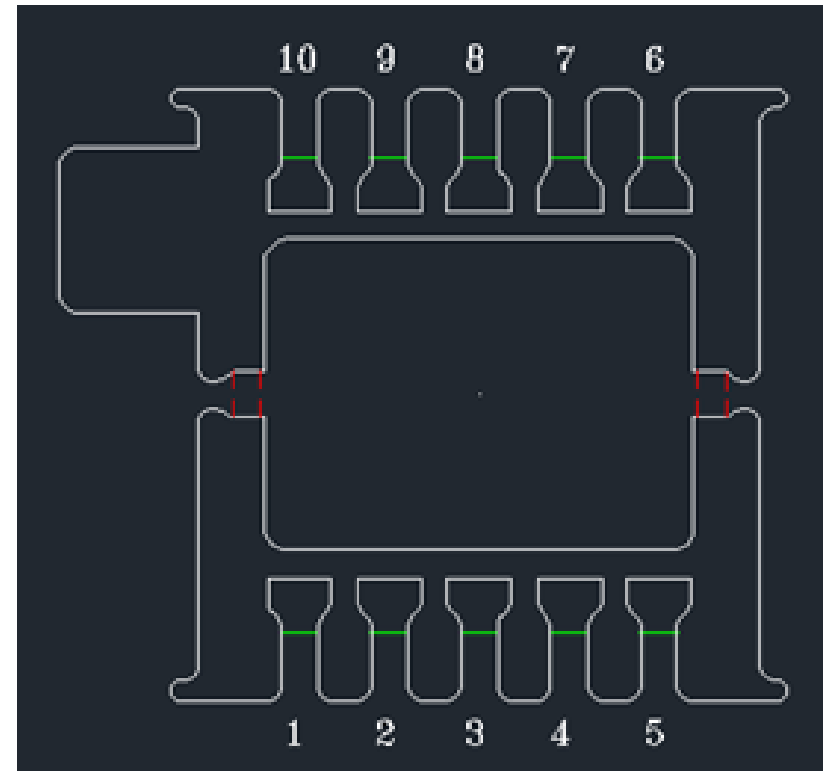
# Lead Frame Comparison

## NSEB



<b>Lead-Frame Material</b>	C7025
<b>Lead-Frame Paddle Size</b>	82x94 mil
<b>Lead-Frame Lead Lock</b>	No

## NSEB



<b>Lead-Frame Material</b>	C7025
<b>Lead-Frame Paddle Size</b>	68x94 mil
<b>Lead-Frame Lead Lock</b>	Yes



## **QUALIFICATION REPORT SUMMARY**

**PCN #: ASER-15HQCX332**

**Date:  
June 14, 2016**

**Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package. This is a qualification by similarity.**



## **MICROCHIP**

# **PACKAGE QUALIFICATION REPORT**

<b>Purpose</b>	Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package. This is a qualification by similarity.
<b>CCB</b>	2503 & 4903
<b>CN</b>	BC161017
<b>QUAL ID</b>	Q16048 Rev. A
<b>MP CODE</b>	VABA1YE3XA00
<b>Part No.</b>	HV9805MG-G
<b>Bonding No.</b>	A-053196 Rev. B
<b><u>Package</u></b>	
<b>Type</b>	10L MSOP
<b>Package size</b>	3x3 mm
<b><u>Lead Frame</u></b>	
<b>Paddle size</b>	68 x 94 mils
<b>Material</b>	C7025
<b>Surface</b>	Spot Ag Plated
<b>Process</b>	Stamped
<b>Lead Lock</b>	Yes
<b>Part Number</b>	FM0008
<b>Treatment</b>	None
<b><u>Die attach material</u></b>	
<b>Epoxy</b>	2200D
<b>Wire</b>	Au wire
<b>Mold Compound</b>	G600
<b>Plating Composition</b>	Matte Tin





**Manufacturing Information**

<b>Assembly Lot No.</b>	<b>Wafer Lot No.</b>	<b>Date Code</b>
NSEB164100001.000	TSMC915451595.000	1601H4R
NSEB164100002.000	TSMC915451595.000	1601H4V
NSEB164100003.000	TSMC915451595.000	1601H55

**Result**       Pass       Fail       \_\_\_\_\_

10L MSOP (3x3mm) assembled by UTL (NSEB) pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C reflow temperature per IPC/JEDEC J-STD-020D standard.

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
<b>Moisture/Reflow Sensitivity Classification Test (At MSL Level 1)</b>	85°C/ 85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243  ( IPC/JEDEC J-STD-020D)	IPC/JEDEC J-STD-020D	135	0/135	Pass	

<b><u>Precondition</u></b> <b><u>Prior Perform</u></b> <b><u>Reliability Tests</u></b> <b>(At MSL Level 1)</b>	<b>Electrical Test</b> :+25°C System: TMT_HV_NT	JESD22-A113	693(0)	693		Good Devices
	Bake 150°C, 24 hrs System: CHINEE			693		
	85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH			693		
	3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243			693		
	<b>Electrical Test</b> :+25°C System: TMT_HV_NT			0/693	Pass	

## PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>Temp Cycle</b>	<b>Stress Condition:</b> -65°C to +150°C, 500 Cycles System : TABAI ESPEC TSA-70H	JESD22- A104		231		Parts had been pre-conditioned at 260°C
	<b>Electrical Test:</b> + 25°C System: TMT_HV_NT		231(0)	0/231	Pass	77 units / lot
	<b>Bond Strength:</b> Wire Pull (> 4.0 grams) Bond Shear (>20.00 grams)		15 (0)	0/15	Pass	
<b>UNBIASED-HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22- A118		231		Parts had been pre-conditioned at 260°C
	<b>Electrical Test:</b> +25°C System: TMT_HV_NT		231(0)	0/231	Pass	77 units / lot
<b>HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. <b>Bias Volt:</b> 5.0 Volts System: HAST 6000X	JESD22- A110		231		Parts had been pre-conditioned at 260°C
	<b>Electrical Test:</b> +25°C System: TMT_HV_NT		231(0)	0/231	Pass	77 units / lot
<b>High Temperature Storage Life</b>	<b>Stress Condition:</b> Bake 175°C, 504 hrs System: SHEL LAB	JESD22- A103		45		45 units
	<b>Electrical Test :</b> +25°C System: TMT_HV_NT		45(0)	0/45	Pass	

## PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>Solderability</b> <b>Temp 215°C</b>	<b>Steam Aging:</b> Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63,Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	JESD22B-102E	22 (0)	22  22 0/22	Pass	
<b>Solderability</b> <b>Temp 245°C</b>	<b>Steam Aging:</b> Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	JESD22B-102E	22 (0)	22  22 0/22	Pass	
<b>Physical</b> <b>Dimensions</b>	Physical Dimension, 30 units from 1 lot	JESD22-B100/B108	30(0) Units	0/30	Pass	
<b>Bond Strength</b> <b>Data Assembly</b>	Wire Pull (> 4.0 grams)  Bond Shear (>20.00 grams)	M2011  JESD22-B116	30 (0) Wires  30 (0) bonds	0/30  0/30	Pass  Pass	



**MICROCHIP**

## **QUALIFICATION REPORT SUMMARY**

**PCN #: ASER-15HQCX332**

**Date:  
Aug 05, 2019**

**Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package. This is a qualification by similarity.**



# MICROCHIP

<b>Purpose</b>	Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package. This is a qualification by similarity.
<b>CCB</b>	2929.001 & 4903
<b>CN</b>	ES295627
<b>QUAL ID</b>	Q19076 Rev. A
<b>MP CODE</b>	TAPA44E3XA11
<b>Part No.</b>	MCP33111-10-E/MS
<b>Bonding No.</b>	BDE-005353 Rev. 01
<b><u>Package</u></b>	
<b>Type</b>	10L MSOP
<b>Package size</b>	3 x 3 mm.
<b><u>Lead Frame</u></b>	
<b>Paddle size</b>	82 x 94 mils
<b>Material</b>	C7025
<b>Surface</b>	Ag Spot plated
<b>Process</b>	Stamped
<b>Lead Lock</b>	No
<b>Part Number</b>	FM0009
<b>Treatment</b>	None
<b><u>Material</u></b>	
<b>Epoxy</b>	8200T
<b>Wire</b>	Au wire
<b>Mold Compound</b>	G600
<b>Plating Composition</b>	Matte Tin



# MICROCHIP PACKAGE QUALIFICATION REPORT

## Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
NSEB200400001.000	TC08919468004.400	1917T0M
NSEB200400002.000	TC08919468004.400	1917T0R
NSEB200400003.000	TC08919468004.400	1917T0T

## Result

Pass     Fail     \_\_\_\_\_

10L MSOP assembled by NSEB pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard.

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard / Method	Qty. (Acc.)	Def/S S	Result	Remarks
<b>Moisture/Reflow Sensitivity Classification Test (At MSL Level 1)</b>	85°C/ 85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243  ( IPC/JEDEC J-STD-020E)	IPC/JEDEC J-STD-020E	135	0/135	Pass	

<b>Precondition Prior Perform Reliability Tests (At MSL Level 1)</b>	<b>Electrical Test</b> :+25°C and 125°C System: J750_HD	JESD22-A113	693(0)	693	Pass	Good Devices
	Bake 150°C, 24 hrs System: CHINEE			693		
	85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH			693		
	3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243			693		
	<b>Electrical Test</b> :+25°C and 125°C System: J750_HD			0/693		



# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>Temp Cycle</b>	<b>Stress Condition:</b> -65°C to +150°C, 500 Cycles System : TABAI ESPEC TSA-70H	JESD22- A104		231		Parts had been pre-conditioned at 260°C
	<b>Electrical Test:</b> + 125°C  System: J750_HD		231(0)	0/231	Pass	
	<b>Bond Strength:</b> Wire Pull (> 2.5 grams)		15 (0)	0/15	Pass	
	Bond Shear (>15.00 grams)		15 (0)	0/15	Pass	

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>Solderability</b> <b>Temp 245°C</b>	<b>Steam Aging:</b> Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22  22  0/22	Pass	
<b>Physical</b> <b>Dimensions</b>	Physical Dimension, 10 units from 1 lot	JESD22- B100/B108	30(0) Units	0/30	Pass	
<b>Bond Strength</b> <b>Data Assembly</b>	Wire Pull (> 2.5 grams)  Bond Shear (>15.00 grams)	M2011  JESD22- B116	30 (0) Wires  30 (0) bonds	0/30  0/30	Pass  Pass	